

**Search Notes**

Application/Control No.

10/630,647

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

BECK ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner
348	308 294	7/25/2007	NT
257	291	12/19/2007	NT
257	292	12/19/2007	NT
250	208.1	12/19/2007	NT
358	482	12/19/2007	NT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Updated PGPUB text search - see search history printout.		12/19/2007	NT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	12/19/2007	NT
Updated text search in classes 348, 257, 358 and 250 - see search history printout.	12/19/2007	NT
Updated text search in all databases listed above.	12/19/2007	NT
Discussed at QEM of 2622.	12/19/2007	NT
Discussed with Lin Ye.	12/19/2007	NT
NPL search (Google) - see search history printout.	12/19/2007	NT
Check for any possible continuity and updated Inventorship search - see search history printout.	12/19/2007	NT